Claimed is:

- 1. A method for monitoring cracks in a silica structure comprising: sensing a wave signature of a crack in the silica structure.
- 2. The crack monitoring method of claim 1, wherein the structure comprises sol-gel.
- 3. The crack monitoring method of claim 1, wherein the structure comprises a tubular configuration.
- 4. The crack monitoring method of claim 1, wherein the wave signature is characterized by the presence of electromagnetic energy.
- 5. The crack monitoring method of claim 1, wherein the wave signature is characterized by the presence of acoustic energy.
- 6. The crack monitoring method of claim 5 wherein the step of sensing comprises detecting acoustic energy by a contact detection system.
- 7. The crack monitoring method of claim 5 wherein the step of sensing comprises detecting acoustic energy by a non-contact detection system.
- 8. The crack monitoring method of claim 5 wherein the step of sensing comprises detecting acoustic energy by a combination of a non-contact detection system and a contact detection system.
- 9. The crack monitoring method of claim 1, wherein the step of sensing comprises detecting emissions characterized by the wave signature.
- 10. The crack monitoring method of claim 1, wherein the step of sensing comprises detecting reflected signals characterized by the wave signature.
- 11. The crack monitoring method of claim 10, wherein detecting reflections is performed by Doppler radar.

- 12. The crack monitoring method of claim 1wherein the wave signature is transmitted from a sensor to a computer by a wireless data transmission system.
 - 13. A device for monitoring cracks in a silica structure comprising:a sensor for sensing a wave signature of a crack in a silica structure.
 - 14. The device of claim 13, wherein the silica structure comprises a sol-gel.
- 15. The device of claim 13 wherein the silica structure comprises a tubular configuration.
- 16. The device of claim 13, further comprising:

 a wireless data transmission system for transmitting wave signature sensing information from the sensor to a computer.
 - 17. The device of claim 13, wherein the sensor is a passive device.
 - 18. The device of claim 17, wherein the sensor is a piezoelectric device.
 - 19. The device of claim 13, wherein the passive device is a microphone.
 - 20. The device of claim 13, wherein the sensor is an active device.
 - 21. The device of claim 20, wherein the sensor is a Doppler radar system.
- 22. A silica structure fabrication process development method comprising:

 monitoring cracks in the silica structure by sensing a wave signature of a crack in
 the structure to isolate one or more process steps in which cracking has occurred;

adjusting process parameters in the one or more isolated steps to diminish or eliminate cracking.